

<b>Notice of References Cited</b>	Application/Control No. 10/047,577	Applicant(s)/Patent Under Reexamination DAVIES ET AL.	
	Examiner Tan Dean D. Nguyen	Art Unit 3629	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2,002,015	05-1935	JOHANNES KOSTEN; et. al.	359/544
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
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	K	US-			
	L	US-			
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**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

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